

IO-Link device implementation for sensors and actuator reference design

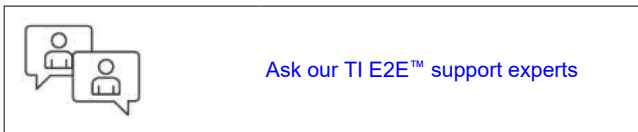


Description

This reference design gives an example implementation of an IO-Link device interface. The design includes the IO-Link device physical layer (PHY) including a low-dropout (LDO) as well as a low-power microcontroller. This combination supports IO-Link COM3 transfer rate and a cycle time of 400 μ s. The MSPM0 microcontroller integrates an internal oscillator, so the MCU is able to run this application without the need of an external crystal, saving cost and space.

Resources

| | |
|-------------------------------|---------------|
| TIDA-010263 | Design Folder |
| TIOX1X2XEVM | Tool Folder |
| LP-MSPM0L1306 | Tool Folder |

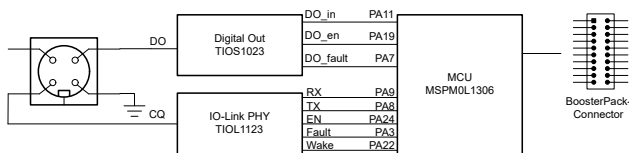


Features

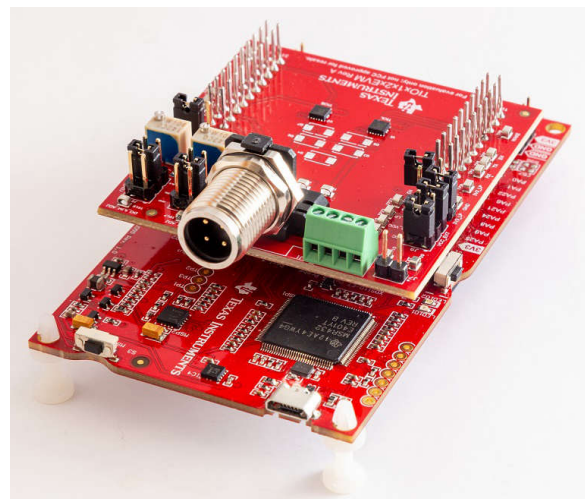
- Crystal-less operation with internal 32MHz oscillator, supporting COM3 and 400 μ s cycle time
- Low-power Arm® Cortex® M0+ microcontroller, running IO-Link device stack developed by [TEConcept](#)
- Two-chip design with PHY internal 20mA LDO
- Device transceiver with integrated EMC protection according to IEC 61000-4-2 (ESD), IEC 61000-4-4 (EFT), and IEC 61000-4-5 (Surge)
- Limited output driver rise time and fall time to minimize overshoots and EMI

Applications

- [Condition monitoring sensor](#)
- [Flow transmitter](#)
- [Actuator](#)
- [Level transmitter](#)
- [Pressure transmitter](#)
- [Temperature transmitter](#)
- [Position sensor](#)
- [Proximity switch](#)
- [Access control](#)
- [Signage](#)



TEConcept



1 System Description

This reference design gives an example implementation of the digital communication interface for sensors or actuators acting as an IO-Link device. The design includes the IO-Link device transceiver (PHY) as well as a microcontroller.

The TIOL112 IO-Link PHY includes a protection circuit according to IEC 61000-4-2 (ESD), IEC 61000-4-4 (EFT), and IEC 61000-4-5 (Surge) as well as a 20mA LDO. This allows designers to build simple systems without the need for external protection devices or additional power supplies.

With a MSPM0L1306 microcontroller, it is possible to power the MCU directly from the LDO output of the PHY and have enough headroom left to also connect additional sensors or ADCs.

Besides the power connection between PHY and MCU, the PHY is also connected to an UART peripheral of the microcontroller. The software running on the MCU has to make sure to control the timing accordingly. The internal oscillator with an external timing resistor provides the needed precision to run in COM3 mode and meeting the requirements by the IO-Link standard. This helps to build small systems, because no external crystal is needed.

The overall combination of the TIOL112 EVM in the form of a BoosterPack™ Plug-in Module, together with an MSPM0L1306 LaunchPad™ Development Kit and the IO-Link stack from TEConcept gives an excellent evaluation platform, because all free interfaces are exposed on the BoosterPack™ Plug-in Module headers, allowing the addition of more sensors, ADCs, or other peripherals.

1.1 Key System Specifications

| COMMUNICATION INTERFACE | IO-Link 1.1.3 |
|---------------------------|--|
| Transfer Rate | COM3 (230400 Baud) |
| Cycle Time | 400µs |
| Integrated EMC protection | <ul style="list-style-type: none"> • ±8kV IEC 61000-4-2 ESD contact discharge • ±4kV IEC 61000-4-4 electrical fast transient • ±1.2kV, 500Ω IEC 61000-4-5 surge |

2 System Overview

2.1 Block Diagram

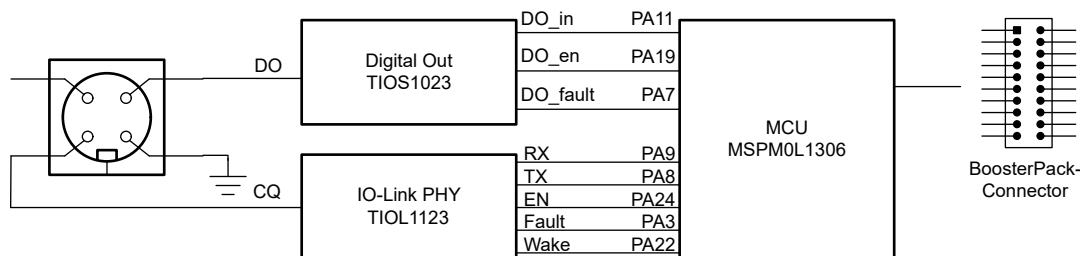


Figure 2-1. TIDA-010263 Block Diagram

2.2 Design Considerations

This design shows an implementation of the communication back end of a sensor or actuator. The implementation consists of TIOX1X2XEVM, which is the evaluation board of the TIOL112, combined with LP-MSPM0L1306, which is the evaluation board of the MSPM0L1306. Both boards can be stacked together and are ready for evaluation.

By default, the TIOX1X2XEVM comes populated with TIOL1123 and TIOS1023, which include a 3.3V regulator. The default jumper settings of this board require the MSPM0 LaunchPad to be powered separately, to use the internal LDO of the TIOL devices, an additional jumper needs to be added on J9 to V_{CC}.

The current limit on the CQ line of the TIOL112 and TIOS102 can be adjusted by using an external resistor. The evaluation board provides a default resistor value of 25.5kΩ, which equals a current of 200mA. Optionally, a potentiometer is on the board to have an adjustable current limit.

In addition to the IO-Link transceiver, the clocking of the device is also an important aspect. The IO-Link standard requires the baud-rate tolerance to be better than 1%. The internal oscillator of the MSPM0 with an external reference resistor can operate much better than the required 1%. Together with a fractional divider for the UART baud-rate generation, it is possible to stay within a tolerance of 1% with the resulting UART baud rate.

IO-Link also needs to have a way to store small amounts of configuration data. This can either be stored in the internal flash or in an external EEPROM. The internal flash has the benefit of already being available and does not require external components. However, the internal flash can be limited in size and requires a sector wide erase. During this erase cycle, the flash cannot be accessed and the time can be longer than the desired IO-Link cycle time. In some cases, the limited amount of erase cycles can also become a problem.

An external I2C EEPROM, FRAM, or flash can require more space and more components, but can solve other issues. Depending on the exact application, the one or the other design can be a good approach.

2.3 Highlighted Products

2.3.1 TIOL112

The TIOL112x family of transceivers implements the IO-Link interface for industrial bidirectional, point-to-point communication. When the device is connected to an IO-Link master through a three-wire interface, the master initiates communication and exchange data with the remote node while the TIOL112x acts as a complete physical layer for the communication.

These devices are capable of withstanding up to 1.2kV (500Ω) of IEC 61000-4-5 surge and feature integrated reverse polarity protection. A simple pin-programmable interface allows easy interfacing with the controller circuits. The output current limit can be configured using an external resistor. TIOL112x devices can be configured to generate wake-up pulse and be used in IO-link master applications. Fault reporting and internal protection functions are provided for undervoltage, overcurrent, and overtemperature conditions.

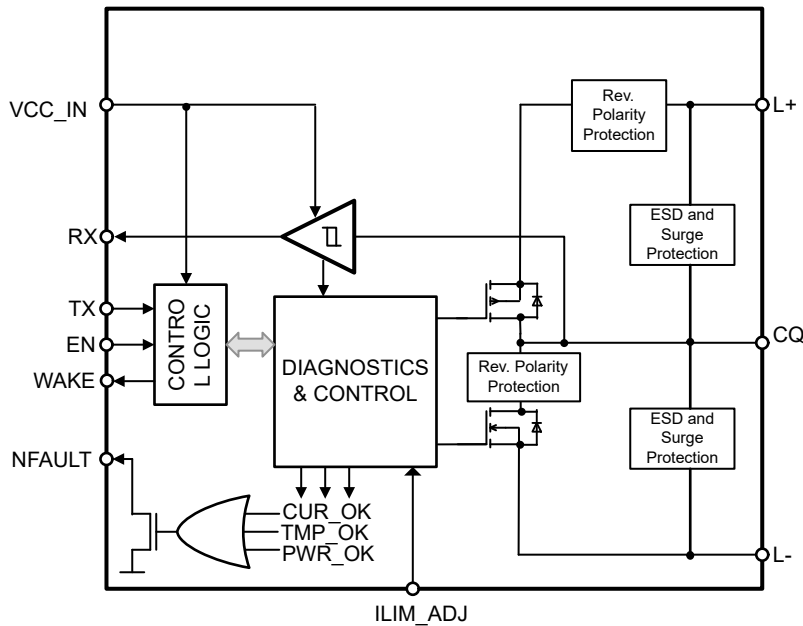


Figure 2-2. TIOL112 Block Diagram

TIOL112 or TIOL112x transceivers implement protection features for overcurrent, overvoltage, and overtemperature conditions. The devices also provide a current-limit setting of the driver output current using an external resistor.

The devices derive the low-voltage supply from the IO-Link L+ voltage (24V nominal) via an internal linear regulator to provide power to the local controller and sensor circuitry.

2.3.2 MSPM0L1306

MSPM0L134x and MSPM0L130x microcontrollers (MCUs) are part of mixed-signal processors (MSPs) highly-integrated, ultra-low-power, 32bit MSPM0 MCU family based on the enhanced Arm® Cortex®-M0+ core platform operating at up to 32MHz frequency. These cost-optimized MCUs offer high-performance analog peripheral integration, support extended temperature ranges from -40°C to 125°C , and operate with supply voltages ranging from 1.62V to 3.6V.

The MSPM0L134x and MSPM0L130x devices provide up to 64KB embedded flash program memory with up to 4KB SRAM. These MCUs incorporate a high-speed on-chip oscillator with an accuracy up to $\pm 1.2\%$, eliminating the need for an external crystal. Additional features include a 3-channel DMA, 16- and 32-bit CRC accelerator, and a variety of high-performance analog peripherals such as one 12-bit, 1.68MSPS analog-to-digital converter (ADC) with configurable internal voltage reference, one high-speed comparator with built-in reference DAC, two zero-drift zero-crossover operational amplifiers with programmable gain, one general-purpose amplifier, and an on-chip temperature sensor. These devices also offer intelligent digital peripherals such as four 16-bit general purpose timers, one windowed watchdog timer, and a variety of communication peripherals including two UARTs, one serial-peripheral interface (SPI), and two I2Cs. These communication peripherals offer protocol support for LIN, IrDA, DALI, Manchester, Smart Card, SMBus, and PMBus.

The TI MSPM0 family of low-power MCUs consists of devices with varying degrees of analog and digital integration allowing for customers to find the MCU that meets the project needs. The architecture combined with extensive low-power modes are optimized to achieve extended battery life in portable measurement applications.

MSPM0L134x and MSPM0L130x MCUs are supported by an extensive hardware and software ecosystem with reference designs and code examples to get the design started quickly. Development kits include a LaunchPad available for purchase and design files for a Target-Socket Board. TI also provides a free MSP Software Development Kit (SDK), which is available as a component of Code Composer Studio™ IDE desktop and cloud version within the TI Resource Explorer. MSPM0 MCUs are also supported by extensive online collateral, training with MSP Academy, and online support through the TI E2E™ support forums.

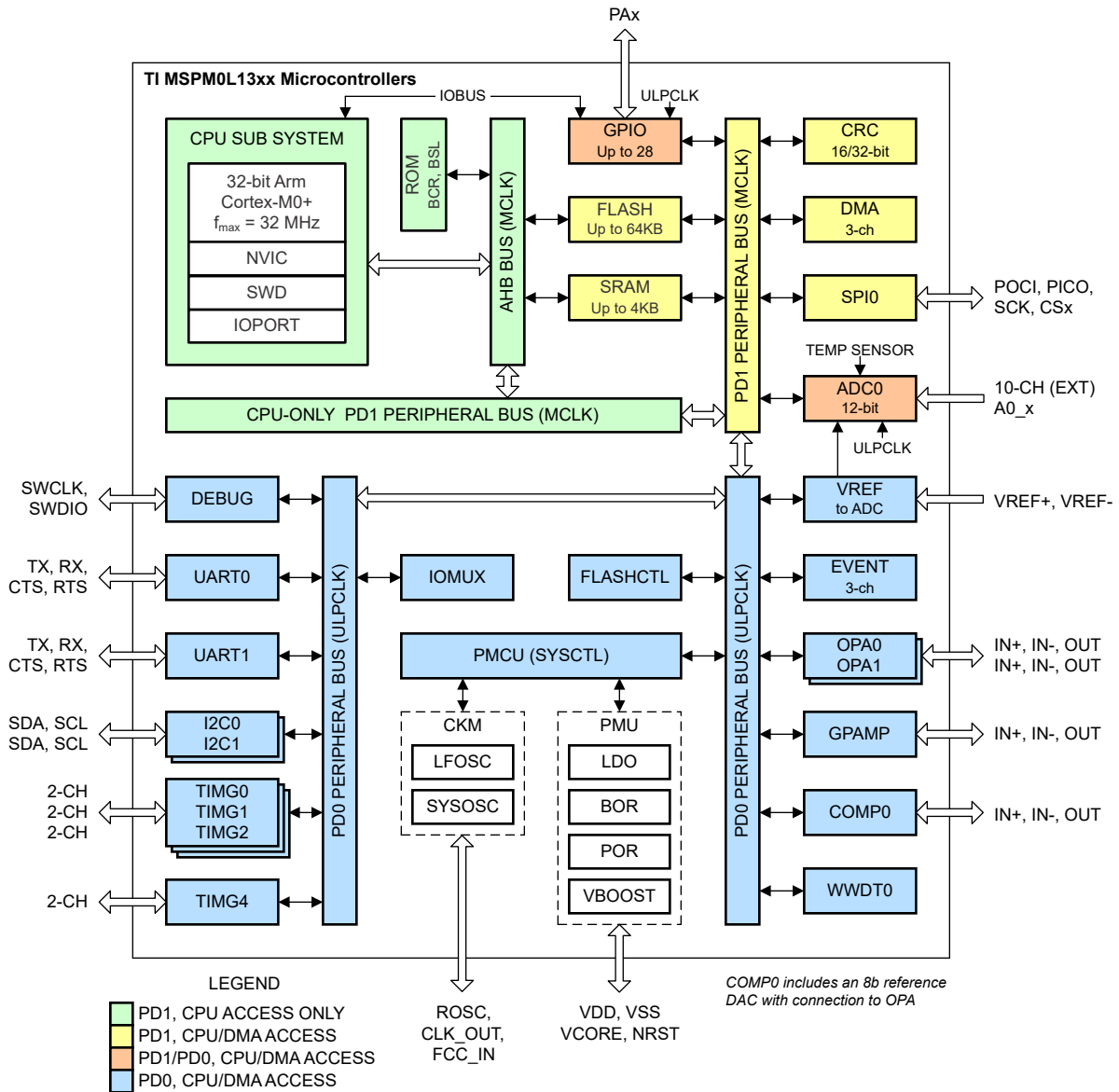


Figure 2-3. MSPM0L130x Functional Block Diagram

3 Hardware, Testing Requirements, and Test Results

3.1 Hardware Requirements

To get the TIOx1x2x EVM working for IO-Link on the MSPM0 LaunchPad Development Kit, make sure to set the jumpers correctly. Use [Figure 3-1](#) as a guideline.

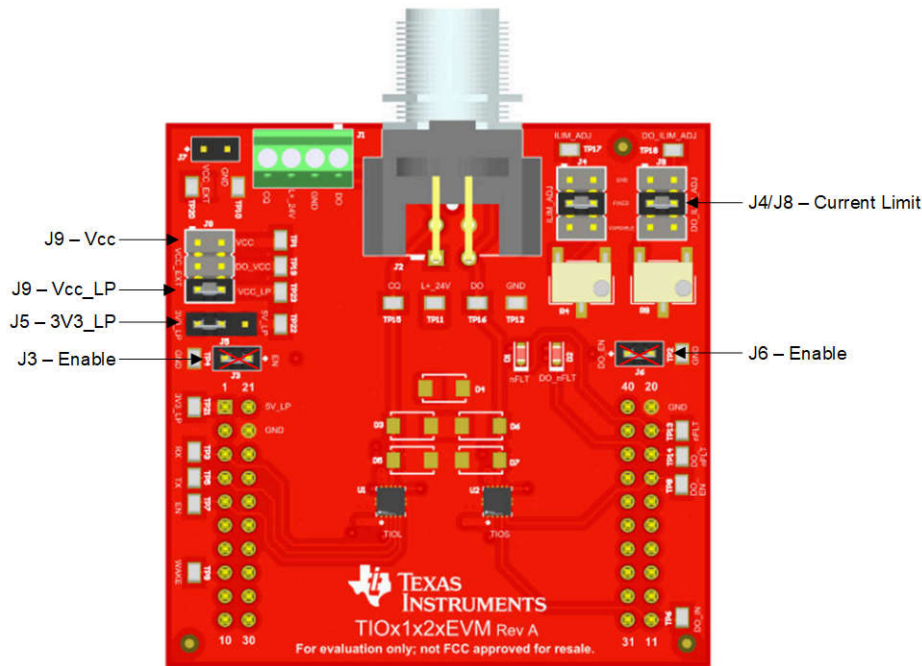


Figure 3-1. TIOx1x2xEVM Jumper Settings

To be able to control the TIOLs enable line, remove J3; otherwise, the IO-Link stack is not able to control the enable line and therefore the TIOL112 driver. The driver is not damaged, but causes a fault.

Also J6 must be removed, this is the enable line of the additional digital output device. The reason behind this change is not about enabling the device, but this line is shared with the SWDIO, so one of the debug lines. Pulling this line to GND with this jumper prevents debugging the microcontroller.

J9 and J5 control the power supply. As long as the TIOx1x2xEVM is not modified (and assembled with TIOL1123), always set J5 to 3V3_LP. J9 allows control of where the design is powered from. With a jumper on Vcc_LP, the LaunchPad Development Kit needs a dedicated power supply. To power the LaunchPad from the L+ line and the linear regulator inside the TIOL1123, also set a jumper on VCC.

Table 3-1. TIOx1x2xEVM Jumper Configuration

| JUMPER | CONFIGURATION | COMMENT |
|--------|----------------------|------------------------|
| J3 | Remove | TIOL112 Enable line |
| J4 | Set to fixed | TIOL112 Current limit |
| J5 | Set to 3V3_LP | Power supply selection |
| J6 | Remove | TIOS102 Enable line |
| J8 | Don't care | TIOS102 Current limit |
| J9 | Short Vcc_Lp and VCC | Power supply selection |

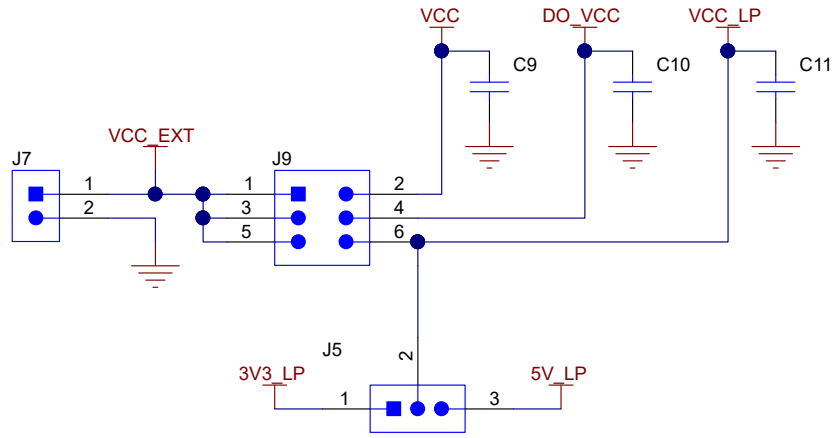


Figure 3-2. Jumper Settings V_{CC}

For further details refer to the [TIOx1x2x EVM User's Guide](#).

Besides the previously-mentioned proper configuration, for proper communication, the MSPM0L1306 must be configured correctly. Figure 3-3 shows the MSPM0L1306 LaunchPad™ Development Kit jumper settings. The default configuration of J16 and J17 must be changed as shown.

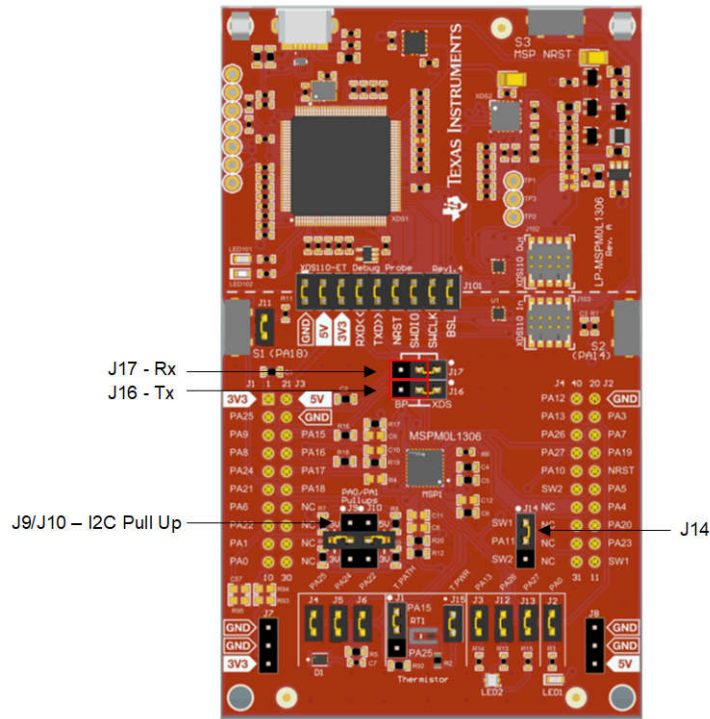


Figure 3-3. MSPM0L1306 LaunchPad™ Development Kit Jumper Settings

Table 3-2. MSPM0L1306 Jumper Configuration

| JUMPER | CONFIGURATION | COMMENT |
|-------------|---------------|--|
| J9 and J10 | Open or 2-3 | Configures a pullup for I2C pins. If an external I2C EEPROM is used, set to 2-3. |
| J14 | 1-2 | |
| J16 and J17 | 2-3 | Configures the UART signals to the BoosterPack headers. |

3.2 Test Setup

To test the TIDA-010263, prepare the two boards as previously described and stack together. The supplied hex file can now be loaded to the MSPM0L1306 device using Code Composer Studio (CCS) or UniFlash.

The UniFlash webpage allows you to scan for connected devices and lists the LP-MSPMO1306. Click on the **Start** button below the device.

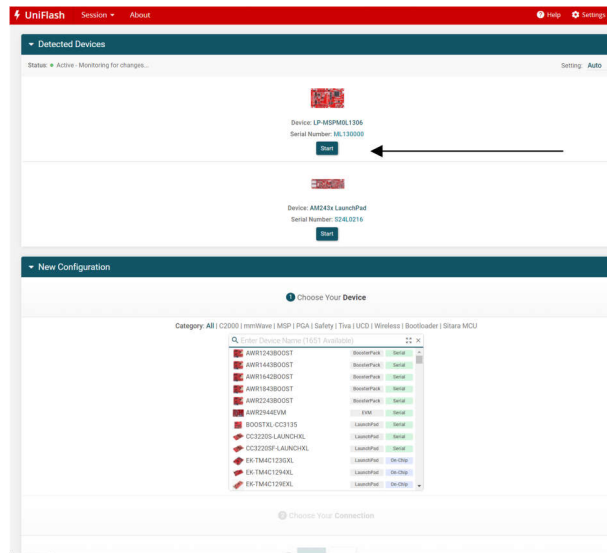


Figure 3-4. UniFlash Start

A screen like Figure 3-5 appears, click the **Browser** button and select the hex file.

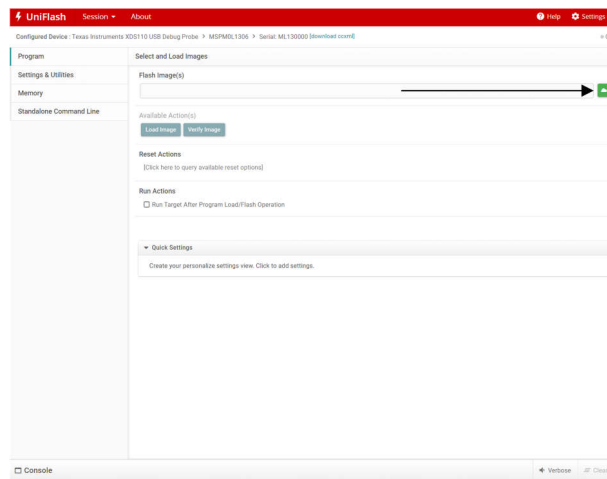


Figure 3-5. UniFlash Select Image

By clicking the *Load Image* button, the hex file is loaded on the MSPM0 device. The debugger is possibly required to allow a firmware update. If this is needed, an additional prompt appears.

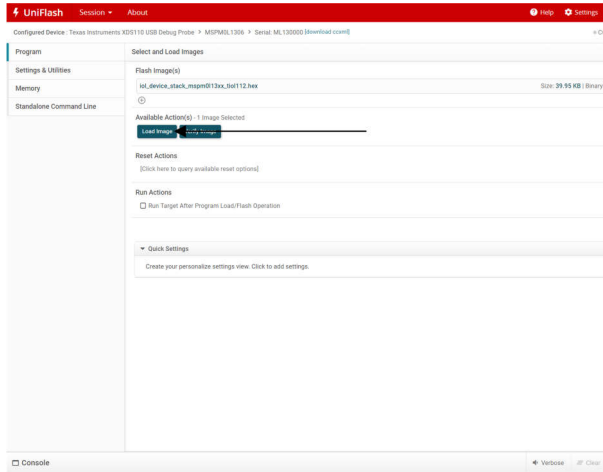


Figure 3-6. UniFlash Flash Image

After the MSPM0L1306 is programmed, the USB connection can be disconnected and TIDA-010263 can be connected to an IO-Link Master, such as TIDA-010234.

To test the reference design, connect TIDA-010234 as shown in [Figure 3-7](#). An IO-Link communication with COM3 and 400µs can be initiated and the timings can be measured.

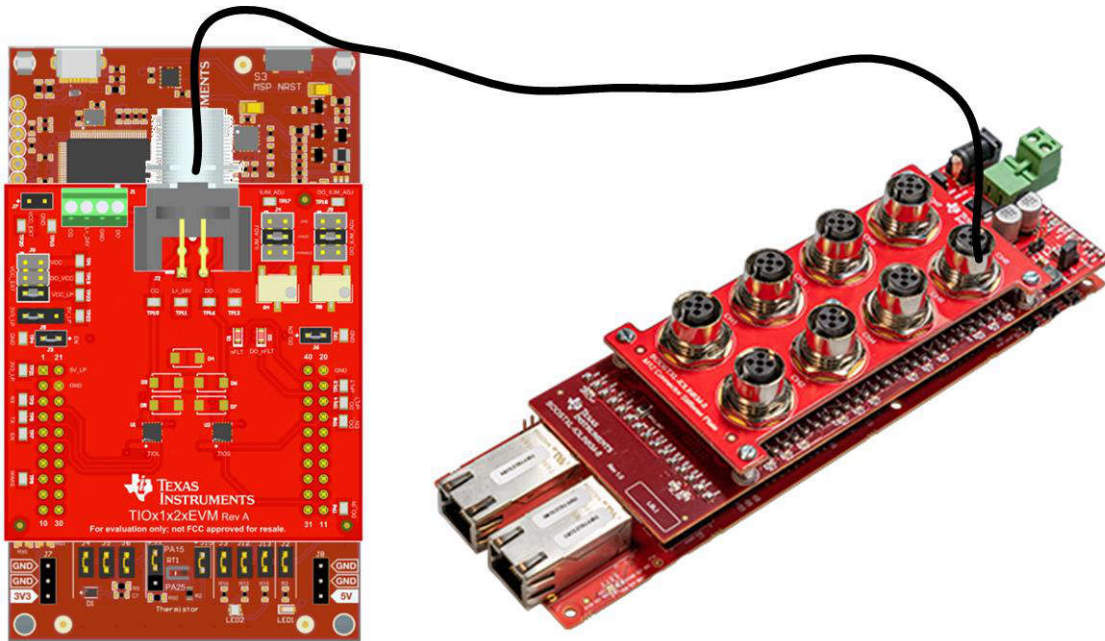


Figure 3-7. Test Setup

The software running on MSPM0L1306 can now enable an IO-Link communication with COM3 and up to 400µs cycle time. The device sends 16 bits of input process data, 8-bit brightness information from a light sensor, and 8-bit temperature information. The device does not accept any output process data.

The RGB LED that is part of the MSPM0L1306 LaunchPad can be controlled through the last 3 bits of the 8-bit indexed service data unit (ISDU) with index 65.

To connect TIDA-010234 to TIDA-010263, start the supplied **IOL Master GUI** and scan for a connected Master (see [Figure 3-8](#)).

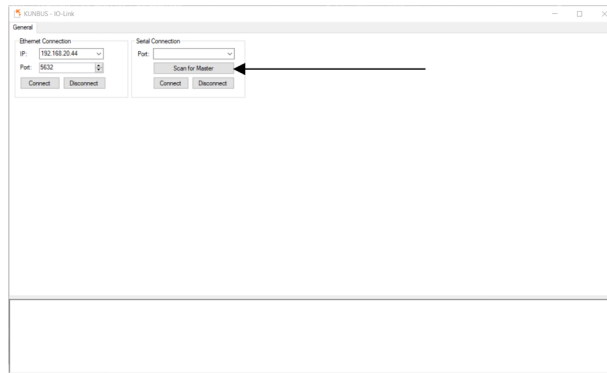


Figure 3-8. TIDA-010234 Search Master

As [Figure 3-9](#) shows, the serial port of the connected Master appears in the *Port:* drop-down menu. Click the **Connect** button to connect to the port.

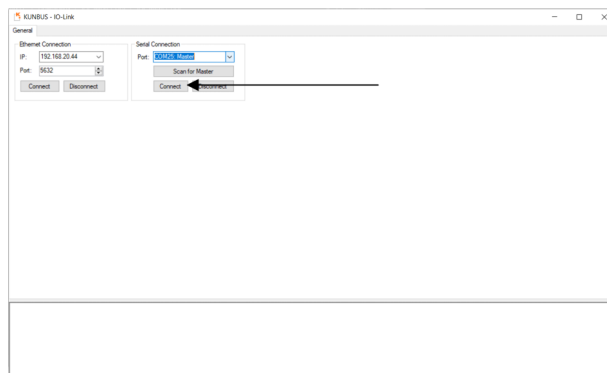


Figure 3-9. TIDA-010234 Connect Master

[Figure 3-10](#) shows where to select the *Std Port Config* tab. Select this tab and configure the port where TIDA-010263 is connected. To do so leave the default settings and click the *Set Port Config* tab.

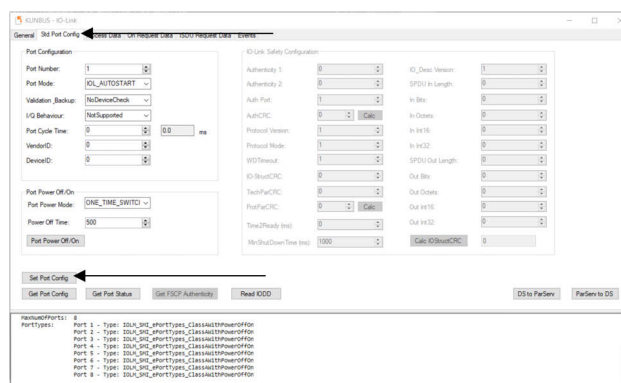


Figure 3-10. TIDA-010234 Configure Port

The IO-Link Master can now establish a connection in COM3 with a 400µs cycle time. This can be verified, by clicking the *Get Port Status* button (see Figure 3-11). The established transmission rate and cycle time appears in the lower tab of the GUI.

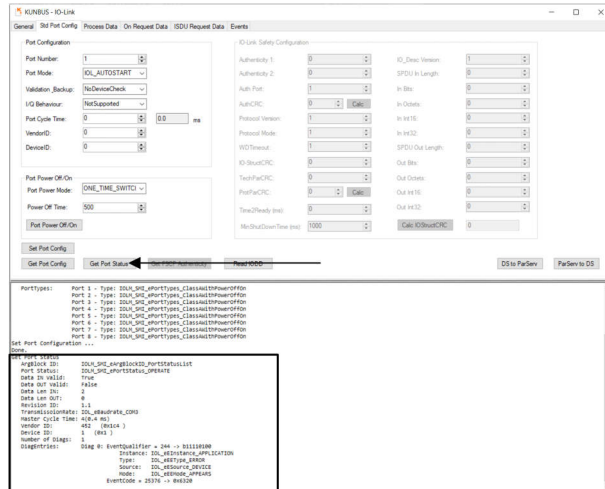


Figure 3-11. TIDA-010234 Port Status

Data can now be read and written. To read process data, switch to the *Process Data* tab and select the *Read* button.

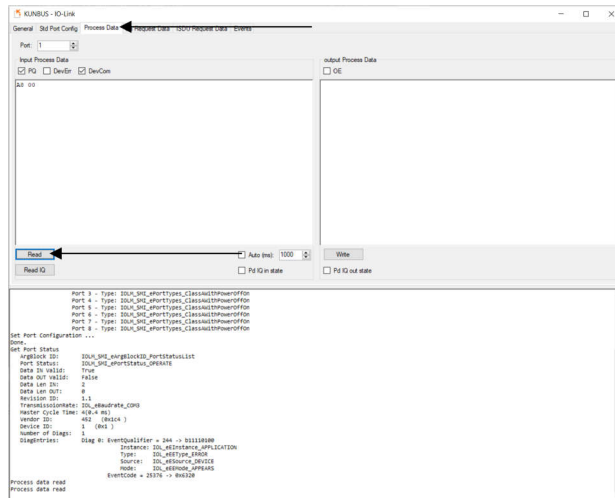


Figure 3-12. TIDA-010234 Process Data

3.3 Test Results

Table 3-3 shows the physical layer tests according to the IO-Link test specification and the results of this reference design.

Table 3-3. Physical Layer Tests

| ID | NAME | CONFIGURATION | SPECIFICATION (CLAUSE) | RESULT |
|--------------|------------------------------|--|--|--|
| SDCI_TC_0011 | TCD_PHYL_INTF_ISD | Measurement of the static power supply current at the L+ of the device | see 5.3.2.3, Table 6 | ISDIOLmax (VSD = 18V): 12.3mA ISDIOLmax (VSD = 30V): 13.6mA |
| SDCI_TC_0012 | TCD_PHYL_INTF_ISIRD | The current and communication of the device is monitored upon power-on: The device charge requirements and behavior at power-on are verified at minimum and maximum power supply conditions. | see 5.3.2.3, Table 6 and 5.4.1, Table 10 | QISD (VSD = 18V): < 3.5mA STARTUP count (VSD = 30V): 1 QISD (VSD = 18V): < 3.5mA STARTUP count (VSD = 30V): 1 |
| SDCI_TC_0013 | TCD_PHYL_INTF_VRESHIGH | Driver capability of the device high-side driver. Measurement of the voltage drop between supply L+ and C/Q ⁽¹⁾ output under a load condition of 50mA. | see 5.3.2.4, Table 7 | VCQ (VSD = 18V): 0.13V VCQ (VSD = 30V): 0.13V |
| SDCI_TC_0014 | TCD_PHYL_INTF_VRESLOW | Driver capability of the device low-side driver. Measurement of the voltage drop between negative supply L- and C/Q output at sink current of 50mA. | see 5.3.2.4, Table 7 | VCQ (VSD = 18V): 0.13V VCQ (VSD = 30V): 0.13V |
| SDCI_TC_0015 | TCD_PHYL_INTF_IQQD | Measurement of the quiescent current into C/Q in receive mode | see 5.3.2.4, Table 7 | ICQ (VSD = 18V, VID = 13V): < 1μA ICQ (VSD = 18V, VID = VSD): < 1μA ICQ (VSD = 30V, VID = 13V): < 1μA ICQ (VSD = 30V, VID = VSD): < 1μA |
| SDCI_TC_0016 | TCD_PHYL_INTF_VTHHD | Measurement of the threshold voltage for high level at the C/Q | see 5.3.2.2, Table 5 | VID at Transition 0 → 1 (VSD = 18V): 11.1V VID at Transition 0 → 1 (VSD = 30V): 11.1V |
| SDCI_TC_0017 | TCD_PHYL_INTF_VTHLD | Measurement of the threshold voltage for low level at the C/Q | see 5.3.2.2, Table 5 | VID at Transition 1 → 0 (VSD = 18V): 10.4V VID at Transition 1 → 0 (VSD = 30V): 10.4V |
| SDCI_TC_0018 | TCD_PHYL_INTF_VHYSD | Calculation of the hysteresis voltage at C/Q based on VTHHD and VTHLD | see 5.3.2.2, Table 5 | VHYSD (VSD = 18V): 0.7V VHYSD (VSD = 30V): 0.7V |
| SDCI_TC_0300 | TCD_PHYL_INTF_VOLTRANGECQ | The device behavior is tested after exposure to signal voltages exceeding the supply voltage | see 5.3.2.2, Table 5, VII and VIH | Communication established |
| SDCI_TC_0027 | TCD_PHYL_INTF_TRENHIGH | The device releases the high-side output driver after successful reception of a wake-up request. Measure wake-up receive enable delay of the device with high signal at C/Q. The delay time is measured with a resistive voltage divider applied between L+ to C/Q and C/Q to L. | see 5.3.3.3, Table 10 | t _{REN} at C/Q = high: 93μs |
| SDCI_TC_0028 | TCD_PHYL_INTF_TRENLOW | The device shall release the low-side output driver after successful reception of a wake-up request. Measure wake-up receive enable delay of the device with C/Q low. The delay time is measured with a resistive voltage divider applied between L+ to C/Q and C/Q to L. | see 5.3.3.3, Table 10 | t _{REN} at C/Q = low: 94μs |
| SDCI_TC_0304 | TCD_PHYL_INTF_UARTTRANSDelay | The delay time between two consecutive UART frames of a device reply message is measured. | see A.3.4, equation (A.4) | t _{2min} : 0 T _{BIT} t _{2max} : 0 T _{BIT} |
| SDCI_TC_0305 | TCD_PHYL_INTF_RESPONSETIME | The delay time between Master messages to device reply message (end of last UART frame to begin of first UART frame) is measured. | see A.3.5, equation (A.5) | t _{Amin} : 4.25 T _{BIT} t _{Amax} : 4.25 T _{BIT} |

(1) C/Q = connection for communication (C) or switching (Q) signal (SIO)

3.3.1 TCD_PHYL_INTF_TRENHIGH and TCD_PHYL_INTF_TRENLOW

To measure the t_{REN} time, the device is connected to a 24V power supply. The CQ line is connected to a voltage divider and a signal generator, generating the wake pulse. Figure 3-14 shows this connection. For measuring t_{REN} when the C/Q line is initially high, R₁ = 1.2kΩ and R₂ = 390Ω, when C/Q is low, R₁ = 680Ω and R₂ = 1.2kΩ.

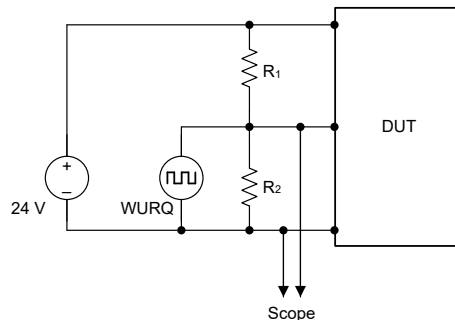
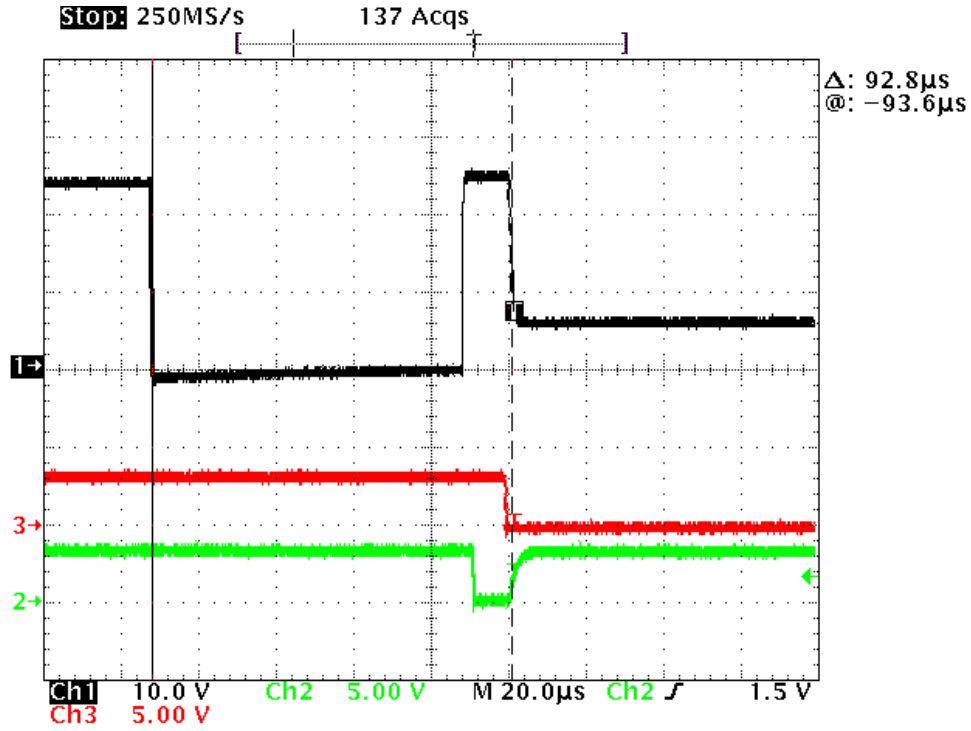


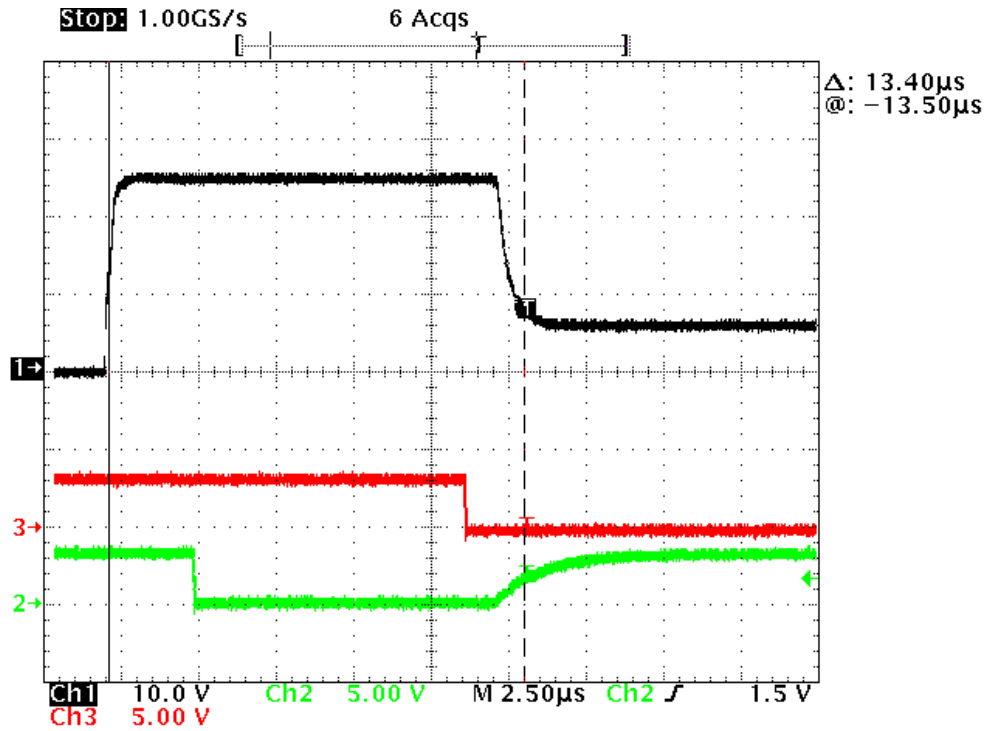
Figure 3-14. Test Setup t_{REN}

The timings of the t_{REN} measurements with a high line are observed in the two scope shots below.



Black = C/Q Line, Red = TIOL112 enable signal, Green = TIOL112 Wake signal

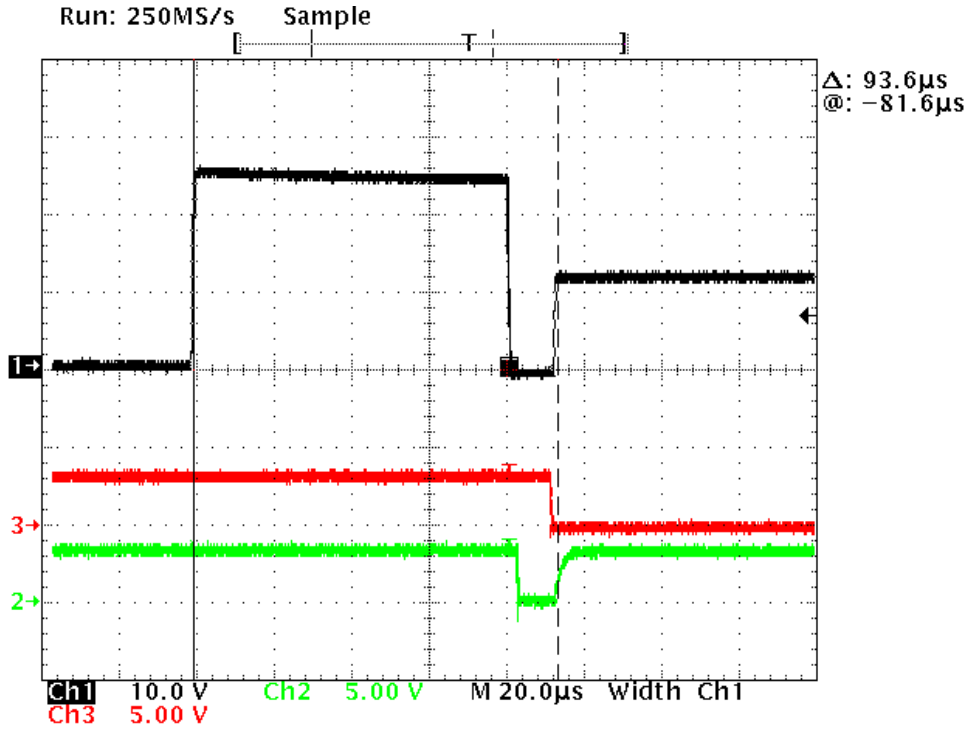
Figure 3-15. t_{REN} High Measurement



Black = C/Q Line, Red = TIOL112 enable signal, Green = TIOL112 Wake signal

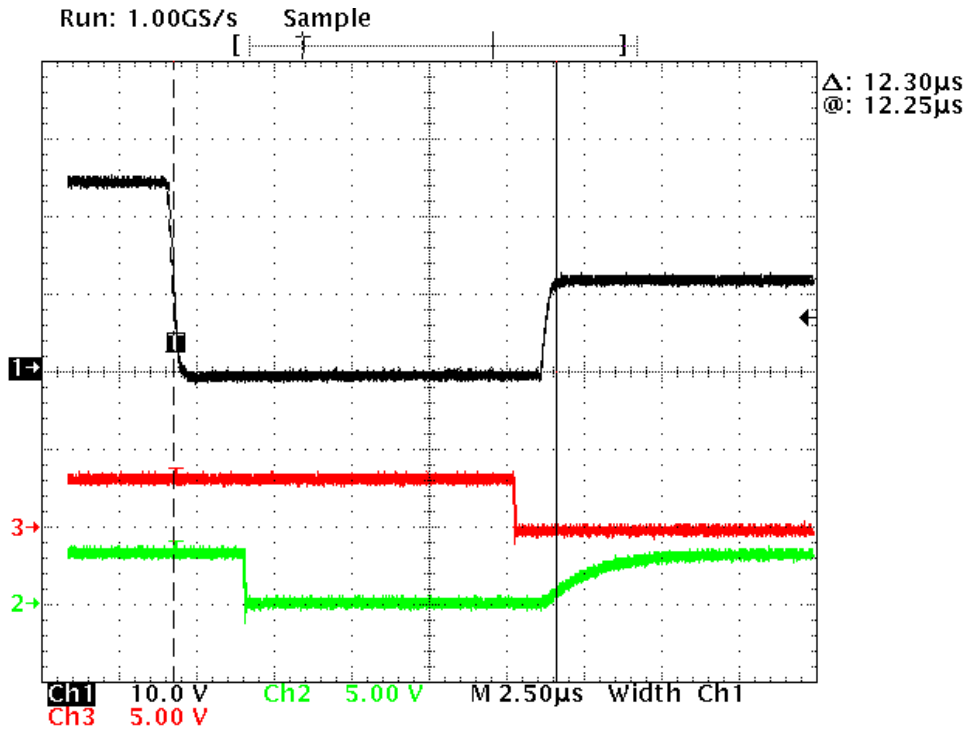
Figure 3-16. t_{REN} High Measurement Zoomed in After Wake Pulse

The next two scope shots show the results for a C/Q line that is initially low.



Black = C/Q Line, Red = TIOL112 enable signal, Green = TIOL112 Wake signal

Figure 3-17. t_{REN} Low Measurement

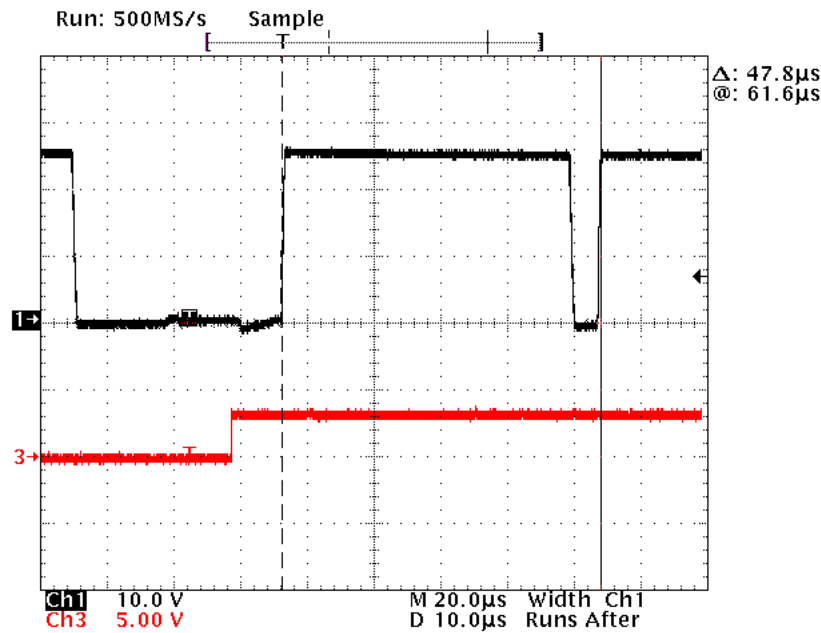


Black = C/Q Line, Red = TIOL112 enable signal, Green = TIOL112 Wake signal

Figure 3-18. t_{REN} Low Measurement Zoomed in After Wake Pulse

3.3.2 TCD_PHYL_INTF_UARTTRANSDELAY

To determine t_2 time, the rising edges of the UART frames on the CQ line are observed to measure the time from one frame to the next. The time of the transmission of eleven bits is then subtracted so that only the time between two frames remain. The time is allowed to be between 0 and 3 times the bit time. In case of COM3, a maximum of $13\mu\text{s}$ is allowed.



Black = C/Q Line, Red = TIOL112 enable signal

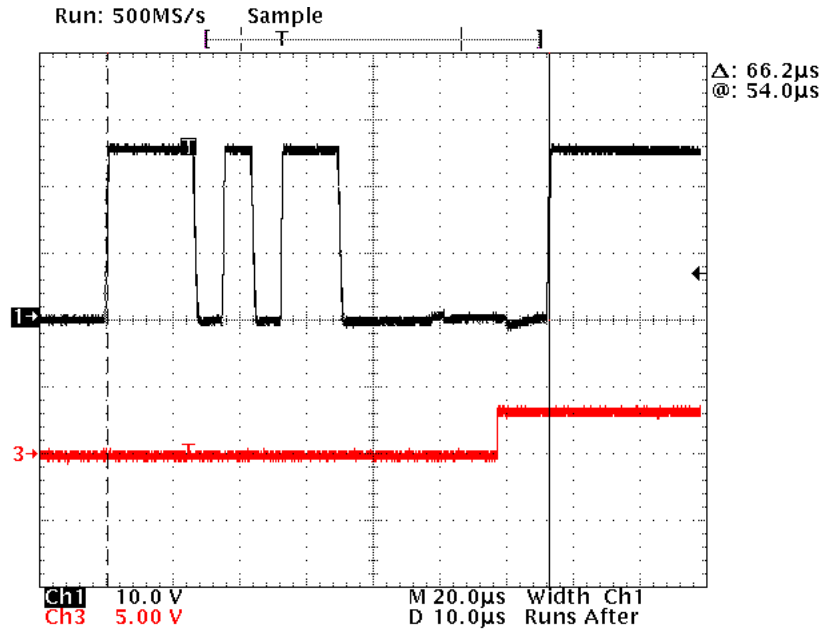
Figure 3-19. T_2 Measurement, First Device Response Start Bit to Second Start Bit Transition

$$47.8\mu\text{s} - 11 \times 4.34\mu\text{s} = 0.06\mu\text{s}, \text{ this equals } 0.01 T_{\text{BIT}} \quad (1)$$

A very low t_2 time is expected, because the UART transmit buffer is reloaded automatically through direct memory access (DMA). The measurement is limited by the time resolution of the measurement.

3.3.3 TCD_PHYL_INTF_RESPONSETIME

To measure t_A , the time between the start bit of the last master message and the start bit of the response from the device is measured. The time of the last message from the master is subtracted. The time is allowed to be between 1 and 10 times the bit time. For COM3 this allows $4.34\mu\text{s}$ and $43.4\mu\text{s}$.



Black = C/Q Line, Red = TIOL112 enable signal

Figure 3-20. TA Measurement, Master Start Bit Transition to Device Start Bit Transition

$$66.2\mu\text{s} - 11 \times 4.34\mu\text{s} = 18.46\mu\text{s}, \text{ this equals } 4.25 T_{\text{BIT}} \quad (2)$$

The measured time is within the limits.

3.3.4 TCD_PHYL_INTF_ISIRD

The inrush current is measured using a current clamp, the detailed waveforms are shown in Figure 3-21 through Figure 3-24. After a first high inrush current, the current is steady short below 10mA. The following scope shots show the current during the first 300ms. The charge going into the device is estimated to be below 3.5mA. The inrush current in Figure 3-21 through Figure 3-24 contains below 0.5mA, and the steady current of 10mA adds another 3mA.

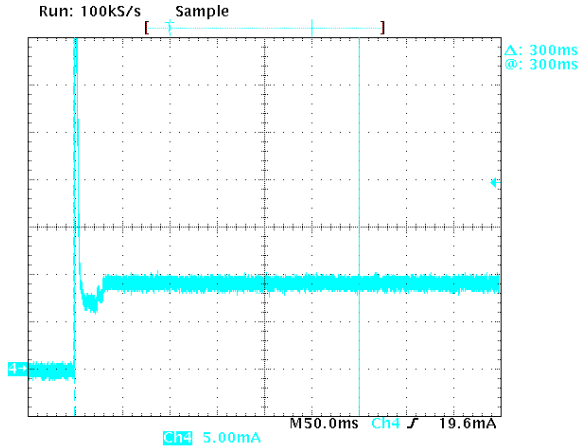


Figure 3-21. ISIRD Measurement at VSD = 18V

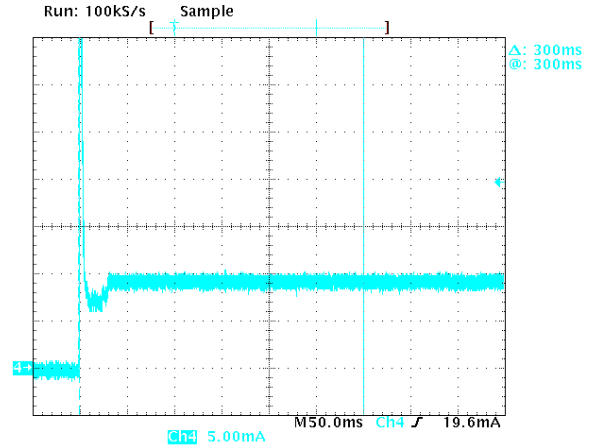


Figure 3-22. ISIRD Measurement at VSD = 30V

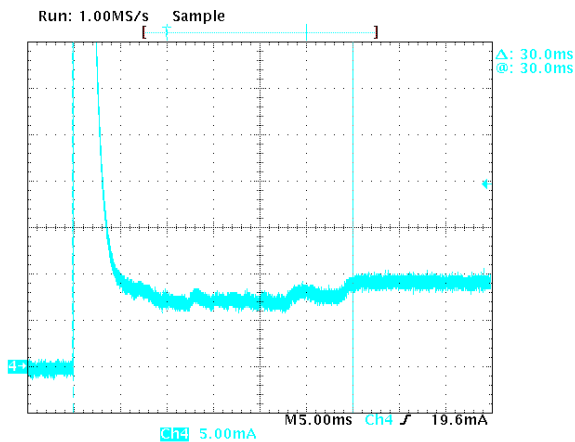


Figure 3-23. ISIRD Measurement Zoomed Into First Inrush (Note the Different Scaling)

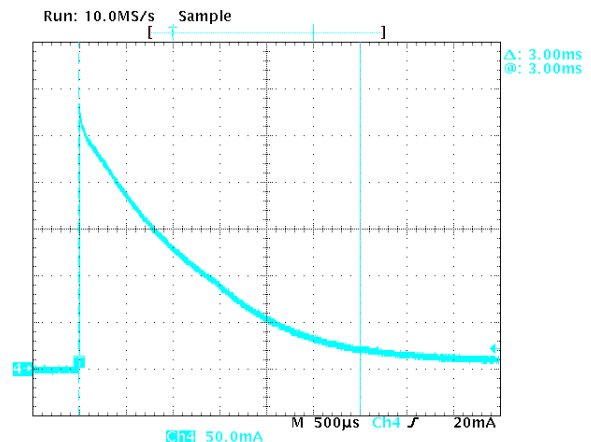


Figure 3-24. ISIRD Measurement Zoomed Into Inrush Current Pulse (Note the Different Scaling)

4 Design and Documentation Support

4.1 Design Files

4.1.1 Schematics

To download the schematics, see the design files at [TIDA-010263](#).

4.1.2 BOM

To download the bill of materials (BOM), see the design files at [TIDA-010263](#).

4.2 Tools and Software

Tools

| | |
|-------------------------------|--|
| LP-MSPM0L1306 | MSPM0L1306 LaunchPad™ development kit for 32MHz Arm® Cortex®-M0+ MCU |
| TIOx1x2xEVM | TIOL112x and TIOS102x evaluation module for IO-Link |
| TIDA-010234 | Eight-port IO-Link master reference design |

4.3 Documentation Support

1. Texas Instruments, [TIOx1x2x Evaluation Module](#) user's guide
2. Texas Instruments, [MSPM0L1306 LaunchPad Development Kit \(LP-MSPM0L1306\)](#) user's guide

4.4 Support Resources

[TI E2E™ support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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5 About the Author

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6 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

| Changes from Revision * (October 2023) to Revision A (June 2024) | Page |
|--|------|
| • Added content to the Test Setup section..... | 8 |
| • Added content to the Test Results section..... | 13 |

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